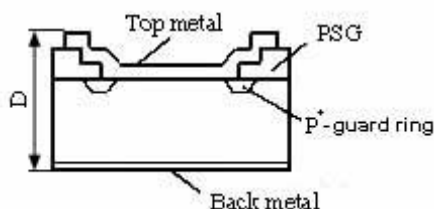
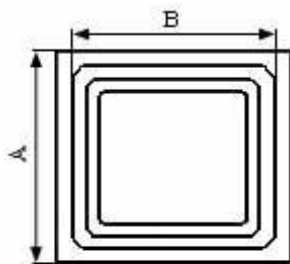




15A/45V. Die Size-130mil.

Electrical Characteristics	Symbol	Unit	Spec. limit	Die Sort
Breakdown Voltage @ $I_R=10mA$	V_{BR}	V	45	50
Average Rectified Forward Current	$I_{F(AV)}$	A	15,0	-
DC Forward Voltage @ 25°C, $I_F=15,0A$	V_F	V	0,50	0,48
Maximum Reverse Current @ 25°C, $V_R=50V$ @ 25°C, $V_R=45V$ @ 125°C, $V_R=45V$	I_R	mA	- 0,200 120,0	0,200 0,150 100,0
Peak Forward Surge Current 8,3ms single half sine-wave superimposed on rated load (JEDEC METHOD)	I_{FSM}	A	300	-
Peak Repetitive Reverse Surge Current @ 2,0µs, f=1kHz., $T_J<150°C$.	I_{RRM}	A	5,0	
Electrostatic Discharge Voltage. JEDEC Method. ESD HBM. Contact.	ESD	kV	±8 (contact)	
Voltage Rate of Change	dV/dt	V/µS	10.000	
Operating Junction Temperature	T_J	°C	150	



DIM	ITEM	µm
A_x	Wafer Form Die Size	3300
A_y		3300
B_x	Top Metal Size	3160
B_y		3160
D	Thickness	300max.
Scribe line Width		80

Top metal:
 a) **Al** – for Wire Bonding;
 b) **Al-Ni-Ag** – for Soldering.
 Backside metal: **Ti-Ni-Ag**.